## Notice of References Cited Application/Control No. 10/802,784 Examiner HUY T. NGUYEN Applicant(s)/Patent Under Reexamination MARUYAMA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,671,458 B2	12-2003	Maruyama et al.	386/95
*	В	US-6,385,389 B1	05-2002	Maruyama et al.	386/95
*	C	US-6,532,336 B2	03-2003	Maruyama et al.	386/95
*	D	US-6,668,135 B2	12-2003	Maruyama et al.	386/95
*	Е	US-6,560,407 B2	05-2003	Maruyama et al.	386/95
*	F	US-6,674,959 B2	01-2004	Maruyama et al.	386/95
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0737980 A2	10-1996	EP	Taira et al	
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.